

**Search Notes**

Application/Control No.

10/808,560

Examiner

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Applicant(s)/Patent under  
Reexamination

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Art Unit

2111

**SEARCHED**

Class	Subclass	Date	Examiner
710	305,313,300,33,110,316	1/11/2006	GCR
715	735	1/11/2006	GCR
365	189.04	1/11/2006	GCR
711	155,203	1/11/2006	GCR
709	223,238	1/11/2006	GCR
709	208,213	1/11/2006	GCR
709	253	1/11/2006	GCR
370	434,230	1/11/2006	GCR
370	401,402	1/11/2006	GCR
370	351,257	1/11/2006	GCR
370	244,464	1/11/2006	GCR
370	492	1/11/2006	GCR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST: US PGPUB, USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	1/10/2006	GCR
WEST: US PGPUB, USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	1/11/2006	GCR
EAST: USPT (see search history printouts)	1/10/2006	GCR
NPL: IEEE Xplore (see search history printouts)	1/10/2006	GCR